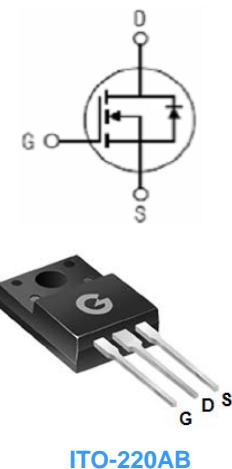


## Features

- Fast Switching.
- Low ON Resistance ( $R_{DS(on)} \leq 0.3\Omega$ ).
- Low Gate Charge (Typical Data: 63nC).
- Low Reverse transfer capacitances (Typical: 25pF).

**HF**


## Mechanical Data

- Case: ITO-220AB.
- Molding Compound, UL Flammability Classification Rating 94V-0.
- Terminals: Matte Tin Plated Leads, Solderable Per MIL-STD-202, Method 208.

## Ordering Information

Part Number	Package	Shipping	Marking Code
BL20N50F	ITO-220AB	50 pcs / Tube	20N50F

## Maximum Ratings (@ $T_c=25^\circ C$ unless otherwise specified)

Symbol	Parameter	Value	Units
$V_{DSS}$	Drain-Source Voltage	500	V
$V_{GSS}$	Gate -Source Voltage	$\pm 30$	V
$I_D$	Continuous Drain Current	20	A
	Continuous Drain Current $T_c=100^\circ C$	12.5	
$I_{DM}^{(Note 1)}$	Pulsed Drain Current	80	A
$E_{AS}^{(Note 2)}$	Single Pulse Avalanche Energy	1500	mJ
$E_{AR}^{(Note 1)}$	Avalanche Energy ,Repetitive	90	mJ
$I_{AR}^{(Note 1)}$	Avalanche Current	4.3	A
$P_D$	Power Dissipation	85	W
$R_{\theta JA}$	Junction-to- Ambient	100	$^\circ C/W$
$R_{\theta JC}$	Junction-to- Case	1.47	$^\circ C/W$
$T_J$	Junction Temperature	150	$^\circ C$
$T_{STG}$	Storage Temperature Range	-55 to +150	$^\circ C$

**Electrical Characteristics (@ $T_c=25^\circ\text{C}$  unless otherwise specified)**

Symbol	Parameter	Test conditions	MIN	TYP	MAX	UNIT
<b>OFF Characteristics</b>						
$V_{DSS}$	Drain-Source Breakdown Voltage	$V_{GS}=0\text{V}, I_D=250\mu\text{A}$	500	-	-	V
$I_{DS}^S$	Drain to Source Leakage Current	$V_{DS}=500\text{V}, V_{GS}=0\text{V}, T_A=25^\circ\text{C}$ $V_{DS}=400\text{V}, V_{GS}=0\text{V}, T_A=125^\circ\text{C}$	-	-	1 100	$\mu\text{A}$
$I_{GSS}$	Gate-body Leakage	$V_{GS}=\pm 30\text{V}, V_{DS}=0\text{V}$	-	-	$\pm 100$	nA
<b>ON Characteristics</b>						
$R_{DS(\text{ON})}$	Static Drain-Source On-resistance	$V_{GS}=10\text{V}, I_D=10\text{A}$	-	0.24	0.3	$\Omega$
$V_{GS(\text{TH})}$	Gate Threshold Voltage	$V_{DS}=V_{GS}, I_D=250\mu\text{A}$	2	-	4	V
Pulse width $t_p \leq 300\mu\text{s}, \delta \leq 2\%$						
<b>Dynamic Characteristics</b>						
$C_{iss}$	Input Capacitance	$V_{GS} = 0\text{V}$ $V_{DS} = 25\text{V}$ $f = 1.0\text{MHz}$	-	2863	-	pF
$C_{oss}$	Output Capacitance		-	285	-	
$C_{rss}$	Reverse Transfer Capacitance		-	25	-	
$g_{fs}$	Forward Trans conductance	$V_{DS}=15\text{V}, I_D=10\text{A}$	-	17	-	S
<b>Switching Characteristics</b>						
$t_{d(on)}$	Turn-on Delay Time	$V_{DD}=250\text{V}, I_D=20\text{A}$ $R_G=25\Omega$	-	33	-	nS
$t_r$	Turn-on Rise Time		-	75	-	
$t_{d(off)}$	Turn-Off Delay Time		-	181	-	
$t_f$	Turn-Off Fall Time		-	83	-	
$Q_g$	Total Gate Charge	$V_{DD}=250\text{V}, I_D=20\text{A}$ $V_{GS}=10\text{V}$	-	63	-	nC
$Q_{gs}$	Gate-Source Charge		-	14	-	
$Q_{gd}$	Gate-Drain Charge		-	24	-	
<b>Source-Drain Diode Characteristics</b>						
$V_{SD}$	Diode Forward Voltage	$I_S=20\text{A}, V_{GS}=0\text{V}$	-	-	1.5	V
$I_S$	Diode Continuous Forward Current		-	-	20	A
$I_{SM}$	Maximum Pulsed Current		-	-	80	A
$t_{rr}$	Reverse Recovery Time	$I_S=20\text{A}, T_J=25^\circ\text{C}$	-	392	-	nS
$Q_{rr}$	Reverse Recovery Charge	$dI_F/dt=100\text{A}/\mu\text{s}, V_{GS}=0\text{V}$	-	3.4	-	$\mu\text{C}$

**NOTE:**

- 1、 Repetitive rating; pulse width limited by maximum junction temperature.
- 2、  $L=10\text{mH}, I_D=17.3\text{A}$ , Start  $T_J=25^\circ\text{C}$ .

## Ratings and Characteristic Curves ( $T_A=25^\circ\text{C}$ unless otherwise noted)

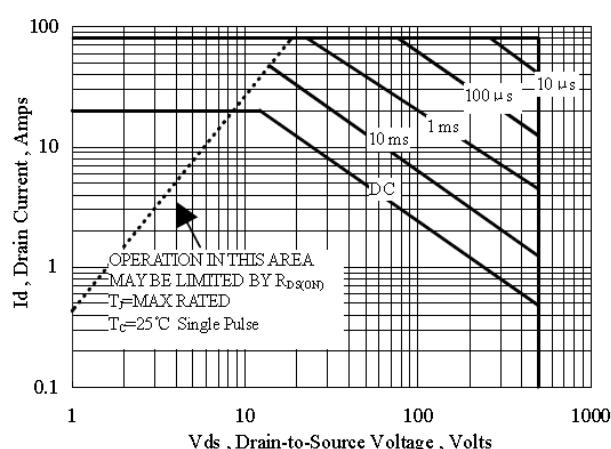


Figure 1 Maximum Forward Bias Safe Operating Area

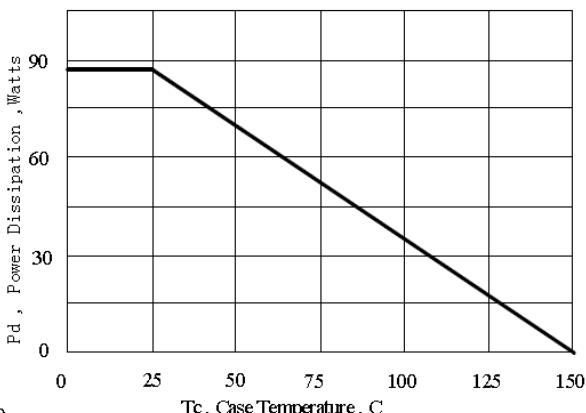


Figure 2 Maximum Power Dissipation vs Case Temperature

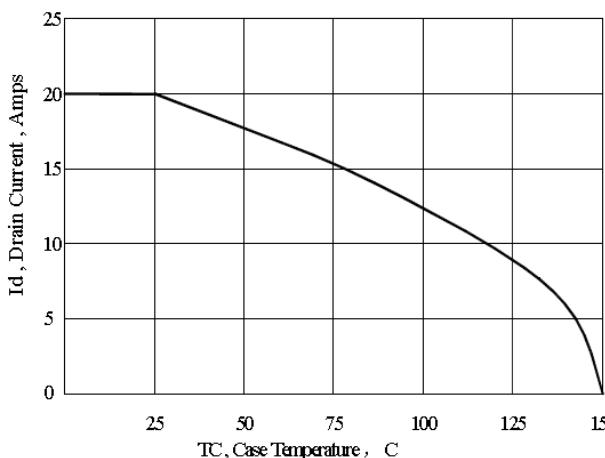


Figure 3 Maximum Continuous Drain Current vs Case Temperature

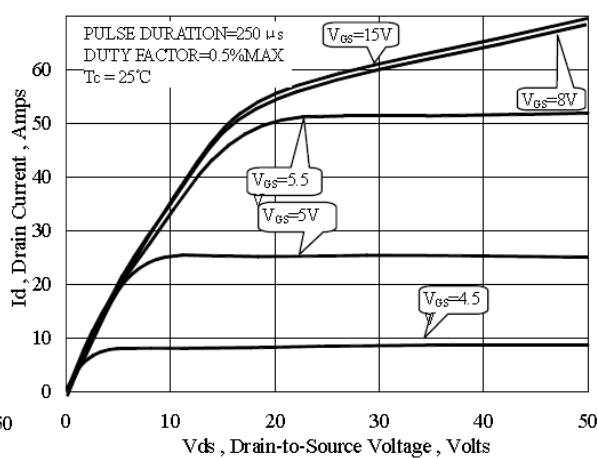


Figure 4 Typical Output Characteristics

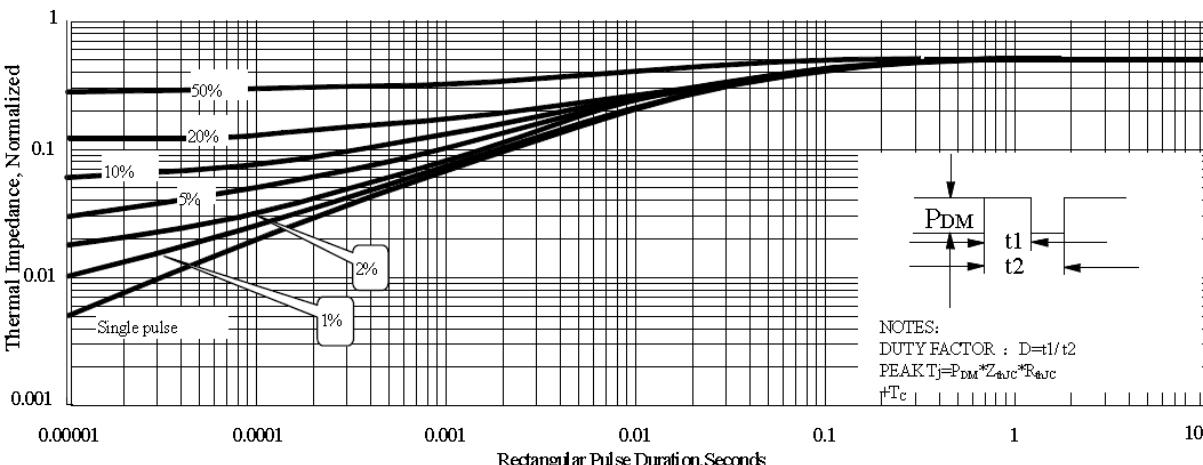


Figure 5 Maximum Effective Thermal Impedance, Junction to Case

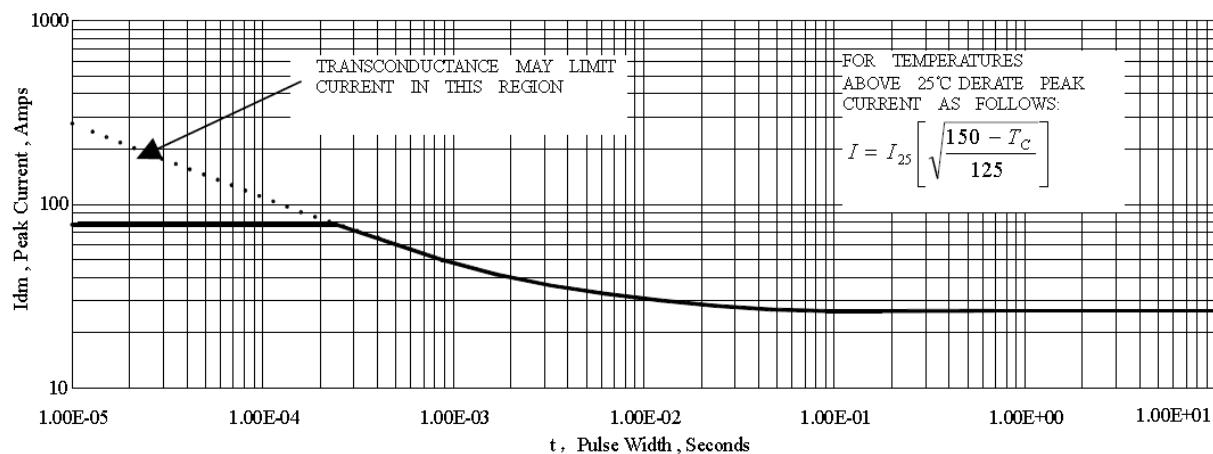


Figure 6 Maximum Peak Current Capability

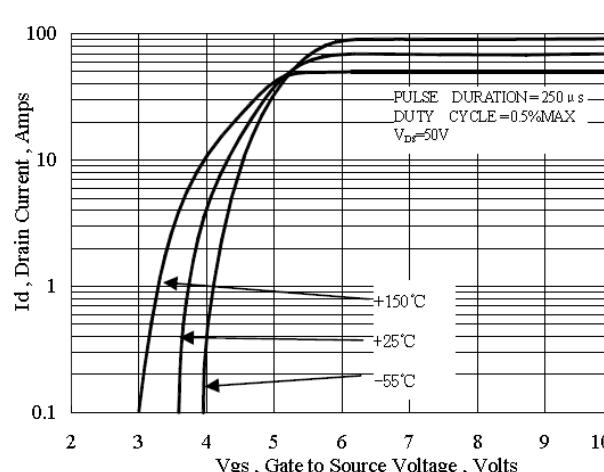


Figure 7 Typical Transfer Characteristics

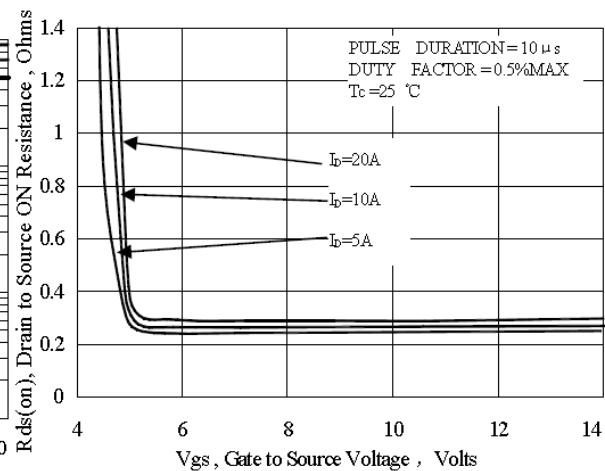


Figure 8 Typical Drain to Source ON Resistance vs Gate Voltage and Drain Current

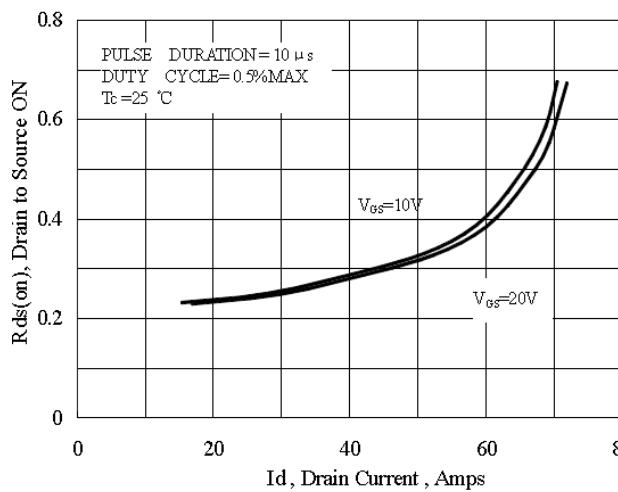


Figure 9 Typical Drain to Source ON Resistance vs Drain Current

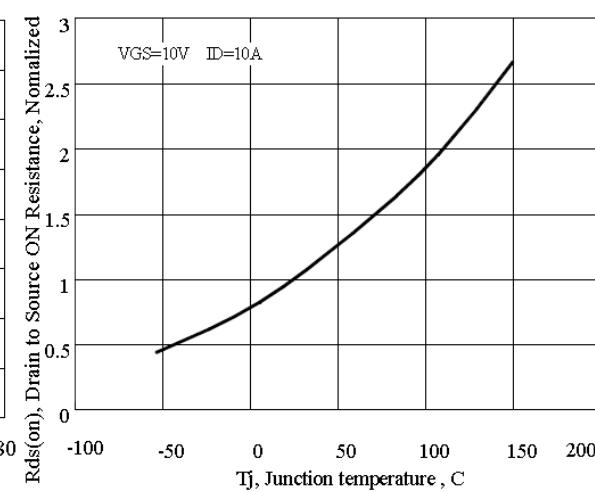


Figure 10 Typical Drian to Source on Resistance vs Junction Temperature

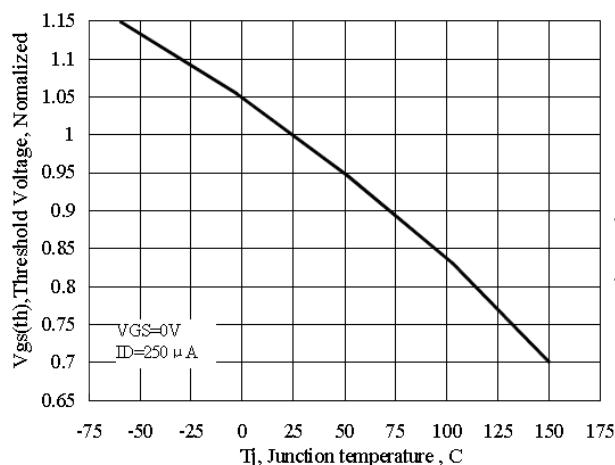


Figure 11 Typical Threshold Voltage vs Junction Temperature

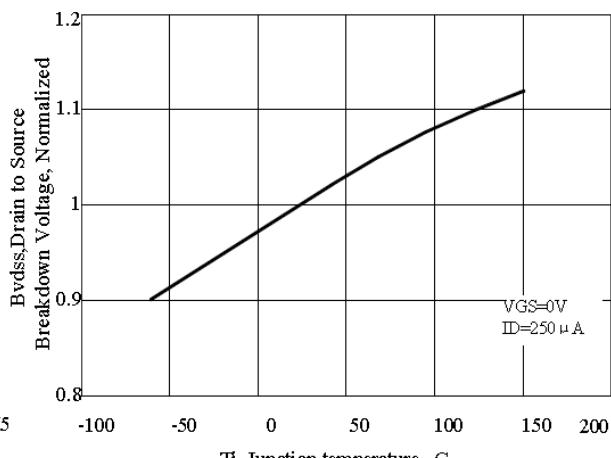


Figure 12 Typical Breakdown Voltage vs Junction Temperature

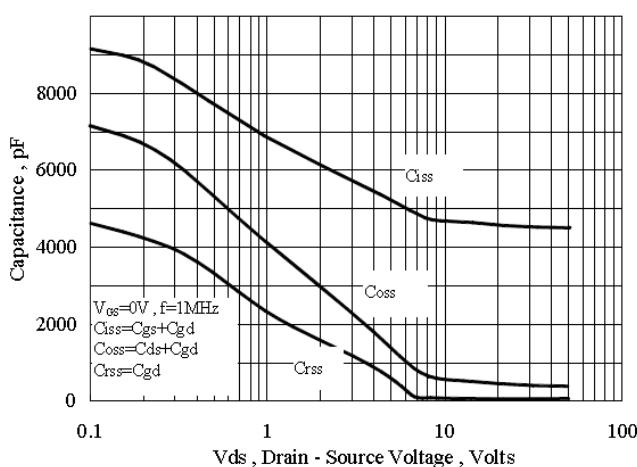


Figure 13 Typical Capacitance vs Drain to Source Voltage

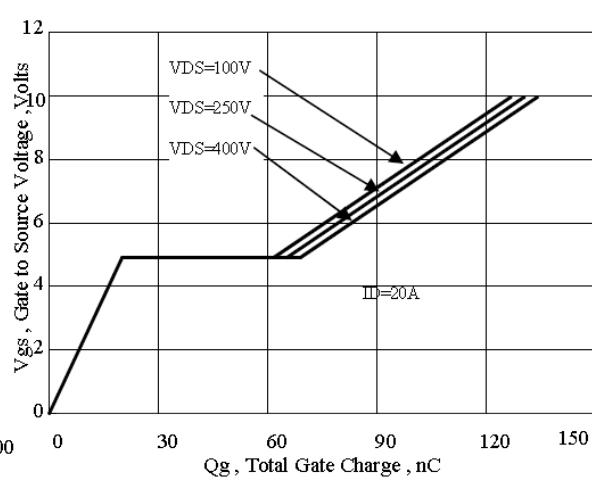


Figure 14 Typical Gate Charge vs Gate to Source Voltage

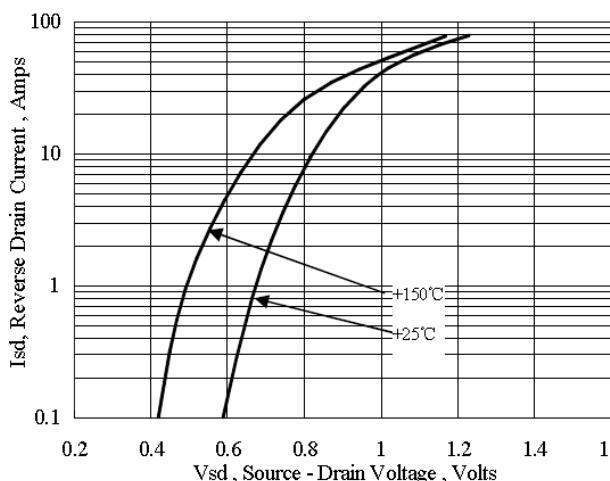


Figure 15 Typical Body Diode Transfer Characteristics

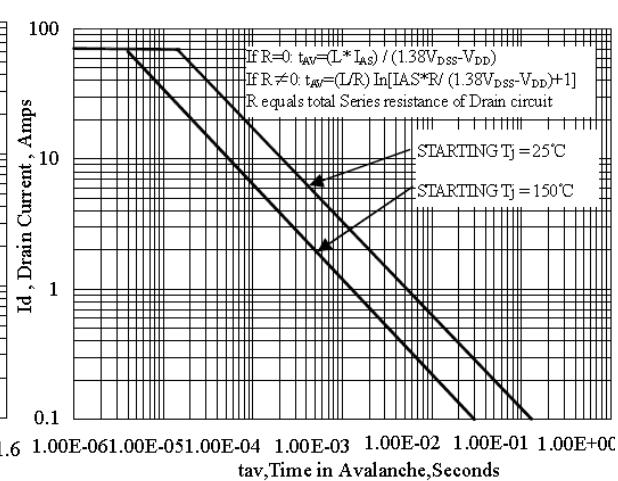
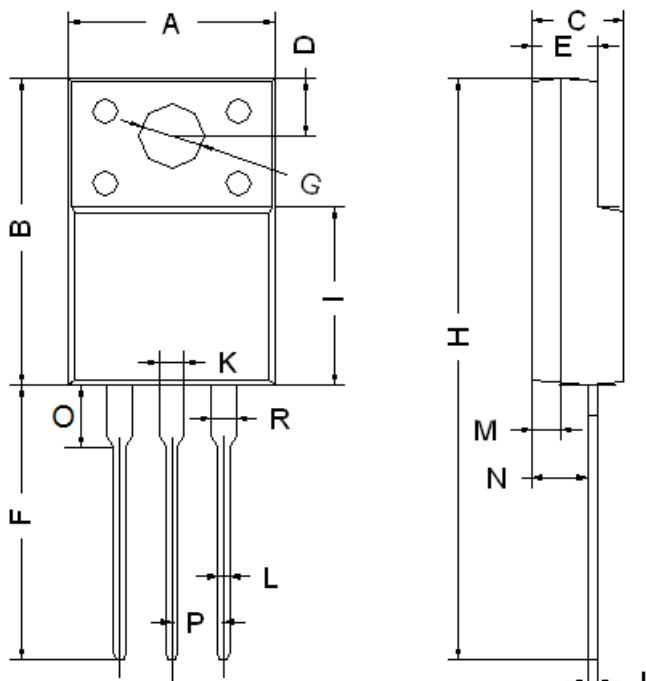


Figure 16 Unclamped Inductive Switching Capability

**Package Outline Dimensions(unit:mm)**
**ITO-220AB**


ITO-220AB		
Dim	Min	Max
A	9.90	10.30
B	14.80	15.20
C	4.30	4.70
D	2.50	2.90
E	2.80	3.30
F	13.00	13.60
G	3.10	3.30
H	28.00	28.60
I	7.90	8.90
J	0.40	0.60
L	0.70	0.90
M	1.30	1.50
N	2.60	2.80
O	2.60	3.10
P	2.45	2.65
K/R	1.10	1.30

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